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PATENT NUMBER and  
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10035061	12/28/2001	356	124	2877	<i>[Signature]</i>

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\*\*CONTINUING DATA VERIFIED:

*WJ*

\*\* FOREIGN APPLICATIONS VERIFIED:

*WJ*

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>	
Foreign priority claimed	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no	ATTORNEY DOCKET NO	
35 USC 119 conditions met	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no	FIS9-2001-0254 us1	
Verified and Acknowledged Examiners's initials	<i>[Signature]</i>		
TITLE : Phase shifted test pattern for monitoring focus and aberrations in optical projection systems			
U.S. DEPT. OF COMM /PAT & TM-PTO-436L(Rev. 12-94)			

NOTICE OF ALLOWANCE MAILED		Assistant Examiner	CLAIMS ALLOWED	
Amount Due	Date Paid		Total Claims	Print Claim for O.G.
ISSUE FEE		Primary Examiner	DRAWING	
TERMINAL DISCLAIMER			Sheets Drwg.	Figs. Drwg.
		Application Examiner		
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